

Comparisons of Non-Invasive Stability Measurements vs. Bode Plots

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More Information: https://www.picotest.com/non-invasive-stability-measurement.html

What's Included Here

- Hardware circuitry including Linear Regulators, POLs, and Switchers were constructed and bench tested
 - <u>Non-Invasive Stability Measurement</u> ('NISM') of Stability Margins and Bode Plots were both recorded
 - In some cases, the circuit were also simulated
 - The Stability Margin vs. Phase Margin results are compared and documented

Note: The testing was performed by AEi Systems.



What is NISM and Why It's a Critical Technology

- Non-Invasive Stability Measurement is a method of determining control loop stability margins without requiring access to the feedback loop
- In many situations it is not possible to access the control loop
 - Examples POLs, Fixed Voltage Regulators, Voltage References, High BW Opamps
 - Integrated Switching ICs that do not allow loop access
 - In other cases it might be impractical to break the control loop because cutting a printed circuit board trace or lifting components might be required
- NISM is computed by converting output impedance to group delay. Then the 'Q' is derived from the group delay and the stability margin from the Q
- The NISM technology is licensed and promoted by <u>Picotest.com</u>
- The measurement capability can be found on various VNAs
 - OMICRON Lab, Keysight, Copper Mountain, Rhode-Schwarz



NISM is Based on Fundamentals

- Dr. R.D. Middlebrook popularized the topic of *Minor Loop Gain*, T_m with his introduction of the extra element theorem which allowed us to assess the stability of power supplies and input filters
- Minor loop gain, based on Nyquist criteria is now one of the most researched electronics topics
- Many articles can be found with an internet search of "forbidden region stability criteria"
- The concept is simple. Break a system into two parts, generally termed a System and a Load and determine the impedance of each part, ZS and ZL

$$Z_{s} \qquad Z_{L} \qquad T_{m} = \frac{Z_{s}}{Z_{L}}$$

• Phase margin is determined by setting |Tm| = 1 and solving for phase



NISM is Based on Fundamentals



A complication exists in that we cannot separate the voltage regulator into two parts, Z_S and Z_L without cutting a trace or removing the capacitor

- NISM software extracts data from impedance and group delay and allows the Z_s and Z_L to be mathematically separated so they can be converted to Stability Margin
- Practically speaking, impedance is measured with a suitable probe in a 1 or 2 port configuration
- The instrument converts the impedance to group delay and Q
- The user positions waveform cursors on the impedance and Q waveforms and the conversion to phase margin is read out on the instrument's screen
- A video of the process can be viewed here, <u>https://www.picotest.com/products_NISM_software.html</u>



Non-Invasive Stability Measurement vs. Bode Plot Measurement

- RH1086 Linear Regulator
- RH1085 Linear Regulator
- LM317 Linear Regulator Various Configurations
- TPS4022 Buck Regulator
- TPS7A4501 Linear Regulator
- LMR10515 Simple Switcher
- TL431 Adjustable Shunt Regulator
- VRG8666 (RH3080) Linear Regulator
- CLC1007 245MHz Opamp



RH1086 Linear Regulator

	NISM	Bode Plot PM
Measured	59 deg	56 deg
Simulated	63 deg	56 deg





RH1086 Linear Regulator



ANALYTICAL HEAVY LIFTING

RH1085 Linear Regulator



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LM317 Linear Regulator, Cap 1



Note: The circuit is from the Picotest VRTS 1 board, <u>https://www.picotest.com/products_VRTS01.html</u>. It was measured using several capacitors in the kit.



LM317 Linear Regulator Cap 4





LM317 Linear Regulator Cap 5





LM317 Linear Regulator Cap 6



	NISM	Bode Plot
Measured	9 deg	8 deg

Measured on the VTRS 1 board, Cap 4 is a 22uF Ceramic



TPS40222 Buck Regulator





TPS7A4501 Linear Regulator 0mA





TPS7A4501 Linear Regulator 1mA





TPS7A4501 Linear Regulator 5mA





LMR10515 'Simple Switcher' POL





VRTS1P5 - TL431 Adj. Shunt Regulator





VRG8666 (RH3080) Linear Regulator





VRG8666 (RH3080) Linear Regulator





CLC1007 245MHz Opamp

Using the Keysight E5061B VNA, with the NISM software, we were able to test the stability of this 245 MHz opamp. The big WOW is that we obtained the (very poor) phase margin from the impedance measurement using NISM (just about 2 degrees). This is a great capability; to be able to accurately assess stability at 100's of MHz or higher without lifting any wires (which would interfere with the measurement). While there is no loop "correlation" for this NISM test, The measured phase margin of 2.36° is not acceptable because signals near the 163MHz bandwidth would become very distorted and fast transitions would see oscillations at this high frequency.



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